

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BEALL ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0049327 A1	12-2001	Hachitani, Yoichi	501/69
*	B	US-2002/0121114 A1	09-2002	Mannemann et al.	65/135.3
*	C	US-2001/0043996 A1	11-2001	Yamada et al.	428/34.4
*	D	US-5,877,101	03-1999	Terai, Katuya	501/32
*	E	US-2001/0017044 A1	08-2001	Mitra et al.	65/134.3
*	F	US-2002/0042337 A1	04-2002	Zou et al.	501/45
*	G	US-3,020,619	02-1962	KOCH WILLIAM J	264/656
*	H	US-2,912,340	11-1959	PINCUS ALEXIS G	501/119
*	I	US-3,365,314	01-1968	WERNER SACK	501/151
*	J	US-4,009,015	02-1977	McCollister, Howard L.	65/33.7
*	K	US-4,560,666	12-1985	Yoshida et al.	501/5
*	L	US-6,303,527	10-2001	Pinckney, Linda R.	501/5
*	M	US-6,531,420	03-2003	Beall et al.	501/5

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	01-308843	12-1989	JP	Senoo	C03C 3/07
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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